Current Status of Single Particle Imaging with X-ray Lasers

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Abstract: The advent of ultrafast X-ray free-electron lasers (XFELs) opens the tantalizing possibility of the atomic-resolution imaging of reproducible objects such as viruses, nanoparticles, single molecules, clusters, and perhaps biological cells, achieving a resolution for single particle imaging better than a few tens of nanometers. Improving upon this is a significant challenge which has been the focus of a global single particle imaging (SPI) initiative launched in December 2014 at the Linac Coherent Light Source (LCLS), SLAC National Accelerator Laboratory, USA. A roadmap was outlined, and significant multi-disciplinary effort has since been devoted to work on the technical challenges of SPI such as radiation damage, beam characterization, beamline instrumentation and optics, sample preparation and delivery and algorithm development at multiple institutions involved in the SPI initiative. Currently, the SPI initiative has achieved 3D imaging of rice dwarf virus (RDV) and coliphage PR772 viruses at ~10 nm resolution by using soft X-ray FEL pulses at the Atomic Molecular and Optical (AMO) instrument of LCLS. Meanwhile, diffraction patterns with signal above noise up to the corner of the detector with a resolution of ~6 Ångström (Å) were also recorded with hard X-rays at the Coherent X-ray Imaging (CXI) instrument, also at LCLS. Achieving atomic resolution is truly a grand challenge and there is still a long way to go in light of recent developments in electron microscopy. However, the potential for studying dynamics at physiological conditions and capturing ultrafast biological, chemical and physical processes represents a tremendous potential application, attracting continued interest in pursuing further method development. In this paper, we give a brief introduction of SPI developments and look ahead to further method development.

Keywords: X-ray free-electron lasers; XFEL; coherent diffraction imaging; single particle imaging; resolution

1. Coherent Diffraction Imaging Using Synchrotron Light Source

High-resolution structure determination of macromolecular and biological particles is an important tool for the life science and biological community [1–4]. Apart from X-ray crystallography and spectroscopy, microscopy is the most widely used technique for structure determination in physical, material and biological sciences. Multiple imaging methods, such as optical microscopy (including general optical microscopy, laser confocal microscopy and super-resolution microscopy) [5–9], electron microscopy [10–13] and X-ray microscopy [14–16] have been employed by researchers. Nevertheless, the resolution of an optical microscope is always limited by the wavelength of the radiation used (~200 nm for visible light). For super-resolution microscopy, the sample has to be labeled, which will
limit the applications of photoactivated localization microscopy (PALM) [17], stochastic optical reconstruction microscopy (STROM) [18] and stimulated emission depletion (STED) [19]. For scanning electron microscopy (SEM), it can only provide surface information [20]. Regarding transmission electron microscopy (TEM) [21], the penetration ability of electrons is a critical issue. The sample thickness has to be less than 50 nm [22], otherwise contrast is reduced due to multiple scattering of the electrons. To obtain structural information below the surface for thick samples, the sample has to be sliced, introducing artifacts in the final images. Compared to electrons, X-rays have a larger penetration depth, making them an ideal probe for most applications in structure determination. However, the scattering cross-section of X-rays is smaller than that of electrons [23]. The scattering efficiency is worse than that of electrons. Actually, neither X-rays nor electrons can achieve atomic resolution due to the limitation of radiation damage [24]. Only when the X-ray or electron pulse is shorter than the atomic motion timescale, such as in the order of 10 fs, could the valid snapshot be captured [25]. Under the same conditions, X-rays are better for thick samples without slicing and electrons are better for weak scattering samples with cryogenic cooling. Classical X-ray imaging methods, such as transmission X-ray microscopy (TXM), scanning transmission X-ray microscopy (STXM) and X-ray fluorescence imaging are based on X-ray optics [26] which will limit the highest obtainable resolution. At the moment, the achievable resolution of focusing optics has broken the 10 nm barrier [27,28]. For X-ray crystallography, the samples have to be crystallized typically to a certain minimum size to obtain high resolution [29]. In addition to crystal growth and phasing, radiation damage is an extra challenge, especially when radiation sensitive samples such membrane or metal containing proteins.

In 1952, D. Sayre underlined in a half-page paper that by measuring the diffraction intensity between the Bragg peaks, the phase problem of non-crystalline samples might be resolved [30]. Since then, oversampling theory [31,32] and different types of phase retrieval algorithms [33–41] have developed rapidly. In 1999, J. Miao and colleagues performed the first successful coherent diffraction imaging experiment [42]. This newly developed coherent diffraction imaging method is a form of lensless microscopy rather than relying on X-ray optics. The theoretical resolution is only limited by the incident light wavelength and the maximum diffraction angle recorded by the detector. The past 18 years have witnessed a great success of coherent diffraction imaging, especially under the use of high flux X-ray light source facilities, such as advanced 3rd generation synchrotron facility Super Photon ring-8 GeV (Spring-8, Hyogo, Japan), European Synchrotron Radiation Facility (ESRF, Grenoble, France) and Advanced Photon Source (APS, Lemont, IL, USA). With developing X-ray instrumentation and phase retrieval algorithms, coherent X-ray diffraction microscopy has been extended to nanoparticles [43–48], mineral materials [49,50], biological cells, bacteria and viruses [51–63]. Meanwhile, different CDI methods also developed quickly, such as Bragg-CDI [43,44,46,48], Fresnel-CDI [64], Keyhole-CDI [65], Reflective-CDI [66] and Ptychography [67,68]. These methods greatly increased the diversity and breadth of applications. Some technologies were incorporated from Cyro-EM, for example, Cryo-CDI [55,56] and wet-CDI [60]. These borrowed technologies make high-resolution imaging without obvious radiation damage possible.

In order to summarize the areas of attention for coherent X-ray diffraction microscopy, ~200 published papers were analyzed. Fifty of them [24,31,32,38,42–87] were selected to generate the word cloud of Figure 1 which shows that reconstruction, diffraction, sample, resolution, structure and coherent are the most used terms during the last 18 years of synchrotron-based CDI papers. Besides, exposure, photons and radiation are also frequently used words. These suggest that published efforts have focused intensely on phase retrieval. It seems the reconstructed real space image was the main aspect of a publication a decade ago. Furthermore, the type of samples and the achieved resolution are also some of the most important parts of the selected papers. For biological specimen, radiation damage has also been a concern. From M. Howells’s summarizing information [24], it can be found that one should be able to image a frozen-hydrated biological sample with CDI at a 10 nm resolution. To our knowledge, the currently published results showed that the best 3D image of biological samples’
resolution is ~30 nm [61], which is a little far away from the 10 nm resolution under the maximum radiation dose tolerance using a third-generation synchrotron light source. This lags behind the atomic resolution achieved by electron microscopy. For the similar samples, such as human chromosome, the resolution of 3D structures with CDI and Cryo-EM is ~120 nm [57] and ~50 nm [88], respectively.

Figure 1. Word cloud of synchrotron-based coherent diffraction imaging published research papers. About 50 widely-read published papers were downloaded. These papers are published during the last 18 years since the first coherent diffraction imaging experiment was conducted successfully in 1999. The main text of the papers was analyzed by open python codes. The frequency of each meaningful word was calculated and then demonstrated by different size and colors. The bigger the size means the larger the frequency. The image shows that reconstruction, sample, phase and resolution are the most used terms for the past 18 years of coherent diffraction imaging research. At the same time, structure, intensity and radiation have also been key topics for biological imaging since 1999. (Original datas were collected from References [24,31,32,38,42–87]. Figure was generated under the help of Github open codes [89]).

The advent of a fourth-generation source, diffraction-limit storage ring (DLSR), opens a promising pathway for CDI [90–92]. The low transverse emittance and beam divergence improve the coherent fraction of the X-ray beam, especially for hard X-rays. The direct result is that the coherent photon of DLSR will be higher than that of current synchrotron light source. The obtainable resolution for CDI scales directly with the spatial coherence (as long as damage can be avoided). At the moment, many facilities around the world intend to update or build DLSR facilities [93], such as ESRF Upgrade Phase II [94], Spring-8 [95], MAX-IV [96], Sirius [97], etc. Looking forward, the investment X-ray facilities are putting into DLSR operations will yield new science possibilities for CDI.

2. Coherent Diffraction Imaging with X-ray Lasers

During the rapid development of CDI, the X-ray light source technologies have also made great progress. Thanks to the advent of ultra-intense and ultrafast X-ray free-electron lasers [98,99], the femtosecond pulses can outrun main radiation damage processes [100] using the so-called “diffraction-before-destruction” strategy [101]. Under proper conditions, XFELs can limit radiation damage and provide clear images of molecules that can otherwise be damaged using a continuous...
illumination. The state-of-the-art serial femtosecond crystallography (SFX) \cite{102} and single particle imaging (SPI) methods \cite{103} have proven to be promising ideas for native structure determination, with the additional benefit of time-resolution for making movies of reactions. Due to noise, detector limitation and demand of large amount dataset for atomic resolution, big data and automatic data analysis are needed to achieve the challenging goal.

Owing to the ultra-intense and ultrafast X-ray pulses generated by FLASH (Hamburg, Germany) \cite{104,105}, LCLS (Menlo Park, CA, USA) \cite{106,107}, SACLA (Hyogo, Japan) \cite{108,109} and FERMI (Trieste, Italy) \cite{110,111}, many exciting CDI results have been obtained. It is worthwhile mentioning that the European-XFEL \cite{112} and PAL-XFEL \cite{113} have recently been commissioned, and that Swiss-FEL \cite{114} is under construction and soon to be commissioned. The Shanghai Soft XFEL \cite{115,116} is under construction, and a hard XFEL facility has also been proposed \cite{117}. We believe that the newly-built facilities will continue to be a great impetus to ultra-small and ultrafast research.

Coherent diffractive imaging experiments with X-ray free-electron lasers (XFEL-CDI) have studied a wide range of samples including man-made objects, nano-materials, clusters, and aerosol particles in the gas phase \cite{101,118–132}. Many of these were used to test the validity of XFEL-CDI and included measurements of the morphology of complex structures, functional imaging method development, and dynamic changes under a stimulus (pump-probe). On the biological side, viruses, bacteria, organelles and associated biological components have been imaged at various resolution levels \cite{133–142} and have helped further develop high throughput imaging methods.

Figure 2 shows typical results from non-biological particles using XFEL-CDI. The first experiment demonstrating the “diffraction-before-destruction” principle using the FLASH soft X-ray free-electron laser by H. Chapman and colleagues \cite{101} is shown on Figure 2a. An intense pulse with $10^{12}$ photons at 32 nm wavelength was transported to a nanostructured non-periodic object. A speckled pattern was obtained before the beam completely destroyed the nanostructure. The diffraction pattern and the reconstructed real-space image showed no measurable effect from radiation damage. The final imaging resolution was estimated to be 62 nm, where the phase retrieval transfer function (PRTF) drops to a value of 1/e. After this successful demonstration of the principle, pump-probe methodologies were applied to XFEL-CDI. Figure 2b,c \cite{120,128} show time-resolved imaging of transforming materials under a visible light stimulus at FLASH and LCLS, respectively. Dynamic changes in man-made structures (Figure 2b) and nanoparticles (Figure 2c) were observed. Such measurements represent examples of the truly unique power of XFELs to study dynamic systems.

Other methods can also be combined with XFEL-CDI to yield further information. Figure 2d \cite{126} shows the functional imaging of multiple nanoparticles. Time-of-flight mass spectrometry was used simultaneously with imaging, which allowed the morphology and chemical content to be captured at the same time by a single shot. Other methods such as fluorescence and emission spectroscopies can also be applied to reveal specific chemical information and correlate it to the structure revealed by imaging.

Three-dimensional imaging is typically not only desired but also necessary to fully understand a system being studied. However, focused XFEL pulses are too intense and destroy the sample typically in one pulse, limiting the information available to two-dimensions in one pulse. Without attenuation, the ultra-intense pulses will destroy almost all particles interacting with the X-ray laser \cite{143}. Three-dimensional images typically cannot be obtained by rotating samples using an X-ray FEL which makes computed tomography (CT) and transmission X-ray microscopy (TXM) regularly performed at synchrotron light sources not particularly suitable for XFELs. Three-dimensional information is obtained using an XFEL by using re-producible particles delivered to the X-ray laser pulses one at a time. In this manner, thousands to hundreds of thousands of diffraction patterns with random orientations are recorded by large pixel array detectors. Using methods such as diffusion maps or threshold methods, valid hits and single-particle hits can be selected and their relative orientation can be determined. After phase retrieval, high-resolution real-space images can be obtained.
Worthy of noted, J. Miao and colleagues developed a single-shot 3D imaging method for high-symmetry objects and demonstrated the idea on gold nanoparticles with X-ray lasers [131]. Figure 2e shows a 3D image of a nanoparticle from SACLA. By using the symmetry of gold nanoparticles, 48 diffraction patterns were generated. The 3D image was obtained after the finding of common arcs and phase retrieval. The final resolution was determined to be ~5.5 nm.

Figure 2. Coherent diffraction imaging of materials with or without pump-probe using X-ray free-electron lasers. (a) The first demonstration of coherent diffraction imaging with X-ray lasers at FLASH in 2006. The concept of “diffraction-before-destruction” was demonstrated at the limited resolution available; (b) Time-resolved diffractive imaging of a man-made sample. Laser-pump X-ray-probe was applied at different time delays. In this case, the sample is seen to get destroyed under the high pump laser intensity and the features are disappearing after 15 ps; (c) Bragg coherent diffraction imaging of gold nanoparticles with hard X-ray lasers was employed at the Linac Coherent Light Source (LCLS). For different time delays, the changes in the diffraction patterns can be used to image phonon dynamics; (d) Morphology and chemical components of aerosol particles were captured by coherent diffraction imaging combined with time-of-flight mass spectrometry at LCLS; (e) Three-dimensional imaging of nanoparticle from SACLA. By using the symmetry of gold nanoparticles, 48 diffraction patterns were generated. The 3D image was obtained after the finding of common arcs and phase retrieval. The resolution as determined by Fourier shell correlation (FSC) is ~5.5 nm. (Figure 2a was reproduced with permission from [101]. Copyright Springer Nature, 2006. Figure 2b was reproduced with permission from [120]. Copyright Springer Nature, 2008. Figure 2c was reproduced with permission from [128]. Copyright The American Association for the Advancement of Science, 2013. Figure 2d was reproduced with permission from [126]. Copyright Springer Nature, 2012. Figure 2e was reproduced with permission from [131]. Copyright Springer Nature, 2014.).

Compared to non-bioparticles, the coherent scattering cross-section of bioparticles is typically much smaller as they are composed of low atomic number elements primarily carbon, oxygen, nitrogen and hydrogen. In other words, the scattering signal of bioparticles is less than other particles when the particle size and photon parameters are the same. For example, the coherent scattering cross-section of gold (19.32 g/cm³) and DNA (C₁₀H₁₁N₄O₆P, 1.70 g/cm³) are 6.5 cm²/g and 0.4 cm²/g under 7 keV. However, the scattering ability of gold is over 100 times stronger than that of DNA. The weak scattering and low signal-to-noise-ratio (SNR) make high-resolution imaging of biological samples more challenging. Figure 3a [135] shows the first coherent diffraction imaging of biological samples at LCLS. High-quality diffraction data were obtained with a single X-ray laser pulse from a mimivirus. The reconstructed exit wavefront (image) shows a full-period resolution of 32 nm. Single cell, virus or bacteria imaging is of potential great importance to disease detection and drug design. It enables the
collections of separate cell images from individual cells and high-throughput imaging over populations of cells can sample unique occurrences. In this big data era, images from populations of genetically identical cells often reveal heterogeneous phenotypes, which can be helpful to group behavior research. Figure 3b [137] shows the high-throughput imaging of heterogeneous cell organelles with 120 Hz X-ray laser pulses from LCLS. Morphology and inner electron density were reconstructed by phase retrieval automatically. This result could pave the way for further biological functional imaging with XFEL. Figure 3c [136] demonstrates the combination of synchrotron XFEL together for one sample where one facility could not solve all challenges. This combined experiment illustrates the differences between facilities. Figure 3d [141] shows the successful demonstration of living cell imaging of cyanobacteria. Living cyanobacteria were injected into the X-ray beam using an aerosol injector. During the short delivery time from solution to the vacuum of the experimental chamber, the cyanobacteria remain in a living state and they were then imaged by coherent diffraction. This demonstrates the capability for the real structure determination of biological samples under near native state. Figure 3e shows the first 3D imaging of biological samples using an XFEL [139]. Hundreds of diffraction patterns with different SNR and random orientations were recorded. After hit finding, pattern classifications, orientation determination and phasing, a 3D real-space volume with a full-period resolution of 120 nm was generated. This demonstration paves the way for 3D single-particle imaging, with the ultimate goal of achieving atomic resolution requiring further effort.

Figure 3. Coherent diffractive imaging of biological samples with X-ray free-electron lasers. (a) First coherent diffraction imaging of biological samples with hard X-ray lasers at LCLS. The sample, mimivirus, is one of the largest known viruses. The total diameter of the particle, including fibrils, is about 750 nm. The full-period resolution of this first demonstration is ~32 nm; (b) High-throughput imaging of heterogeneous cell organelles. Around 70,000 low-noise diffraction patterns were collected within 12 min at LCLS at a frequency of 120 Hz. Real space images with different organelles’ size and shape were phased automatically; (c) Structure determination of RNAi microsponge combining single-shot X-ray free-electron laser (XFEL) diffraction with synchrotron-based coherent diffraction imaging; (d) Living cell imaging of cyanobacteria with XFEL. Living cyanobacteria were injected to the X-ray laser using an aerosol particle injector; (e) The first demonstration of three-dimensional imaging of biological samples. Mimivirus was delivered to the X-ray laser beam, hundreds of random orientation diffraction patterns were collected. After hit finding, single-shot classification and orientation determination, a three-dimensional diffraction volume was obtained. The spatial resolution was estimated to ~125 nm. (Figure 3a was reproduced with permission from [135]. Copyright Springer Nature, 2011. Figure 3b was reproduced with permission from [137]. Copyright Springer Nature, 2014. Figure 3c was reproduced with permission from [136]. Copyright Springer Nature, 2014. Figure 3d was reproduced with permission from [141]. Copyright Springer Nature, 2015. Figure 3e was reproduced with permission from [139]. Copyright American Physical Society, 2015).
3. Single-Particle Imaging with X-ray Lasers

As mentioned above, coherent diffraction imaging with X-ray lasers has undergone a fast development and many high-profile results have been achieved. However, the published resolution has been limited, and there is a huge gap between the current resolution and atomic-scale resolution. In order to deeply investigate the limitations and move forward, start-to-end considerations have to be taken. The light source, such as the photon energy, pulse duration and pulse energy need to be optimized. X-ray instruments, such as optics, focusing mirrors, front-end slits and apertures before the sample, also need to be optimized for the measurement. Sample delivery systems, such as aerosol injectors, liquid-jet injectors and fixed targets, need development, optimization and suitable design for different experiments. Data acquisition system, such as high quantum efficiency (QE) and high dynamic range detectors, online data monitoring and analysis software, phase retrieval algorithms, will greatly affect the efficiency and validity of final images.

To speed up the progress and take full advantage of the scientific community around the world, LCLS launched an international cooperation team in December 2014, the Single-Particle Imaging initiative, which includes more than 100 scientists from 21 institutions over eight countries. A step-by-step roadmap was published where a host of challenges was outlined to guide the required developments. A series of experiments has been dedicated to systematically address the challenges of SPI.

3.1. The Road Map

To achieve atomic-scale resolution, such as 3 Å, the SPI initiative analyzed all the factors that could limit the resolution from the start to the end of the experiment. To initiate this work, workshops and brainstorming sessions were arranged to clarify the steps to undertake. Following the published roadmap [103], the following key challenges were identified:

1. Radiation damage;
2. Start-to-end simulation pipeline;
3. Samples issues;
4. Sample delivery system;
5. Characterization of parasitic scattering and noise;
6. Beam diagnostics and characterization;
7. Data analysis and phase retrieval algorithms development.

3.2. Setup and the Experiment Procedure

Many aspects are required to be specified prior to conducting an SPI experiment. First, the proposed resolution, sample type and size should be defined. Special diagnostics required for the experiment, such as the ion/e⁻ TOF, high speed camera, fluorescence detector and pumping laser system and the space they require should also be taken into consideration. Secondly, the ideal sample-to-detector-distance, photon energy, pulse duration, and pulse energy should be determined. Then, careful alignment of all optics, slits, KB mirrors and large-panel pixel array detectors must carefully be accomplished at the start of the beamtime. Simultaneously, beam characterization, such as the beam profile, the focused beam spot size, beam intensity and position fluctuations, wavefront or arrival time should be diagnosed for further reference. The high harmonic content of the beam should also ideally be tested. Finally, selection of a proper sample delivery method will be of great importance to the background and hit rate. The simple flow chart of the experiment and data process is shown in Figure 4. After alignment of the instrumentation, samples are delivered into the X-ray laser beam path. The forward scattering exit wavefront will propagate downstream and then to be recorded by the detector and this pattern must be oversampled properly. Data processing involves center determination, background subtraction, analog-to-digital units (ADU) to photons conversion, hit finding, pattern classification, and orientation.
determination. Finally, phasing can produce a real-space 3D image. By using PRTF, FSC or other criteria, the spatial resolution could be determined.

3.3. Current Status

Eight experiments have been performed since the start of the SPI initiative. Different samples, such as FIB Au nanostructures, rice dwarf virus (RDV), coliphage PR772 viruses and bacteriophage MS2 virus, were used for the various experiments. The reasons for the sample selection will be discussed in the sample selection section. The main purpose of each experiment was different. For example, amo86615 aimed primarily to collect a lot of diffraction patterns of RDV and PR772. However, the main target for experiment amo11416 was to test sample delivery and collect diffraction data from MS2. To reduce the background from sample delivery, different sample methods were tested.

![Figure 4](image-url)

**Figure 4.** Schematic layout of a single-particle imaging measurement using femtosecond XFEL pulses. Nanoparticles and viruses are injected to the XFEL focus by a particle injector or a fixed target system using thin membranes such as Si$_3$N$_4$ and graphene. High dynamic range, high quantum efficiency and large panel detectors are employed to record patterns. In general, five main steps are required for a single-particle imaging experiment. After sample selection and preparation, they are delivered to the XFEL focus and the patterns are collected by the detector. This produces large data sets requiring advanced automatic processing. Hit finding, background subtraction and detector calibrations have to be applied to reduce the data. By using threshold analysis or diffusion maps, single-shot patterns are selected. After orientation determination and phase retrieval, a real-space three-dimensional image can in principle be achieved.

3.4. Light Source and Instruments

There are seven X-ray instruments at the LCLS. The Coherent X-ray Imaging (CXI) instrument and the Atomic, Molecular & Optical Science (AMO) instrument are the instruments suitable for SPI. The CXI instrument is located in the Far Experimental Hall of LCLS. The hutch is located 440 m far away from the source. The instrument makes use of hard X-ray pulses to perform coherent X-ray imaging and serial femtosecond crystallography experiments. The primary operating photon energy range is 5~11 keV, with some capability for higher harmonics up to 25 keV. Three sample chambers exist with foci of ~5 µm, 1 µm, and 0.1 µm being possible. The AMO instrument is located in the Near Experimental Hall of LCLS and the photon energy range is 280~2000 eV. The focusing optics for the AMO instrument are bendable Kirkpatrick-Baez (KB) mirrors and the focused beam size is estimated to be 1.5~5 µm. In both the CXI and AMO cases, a high-power laser synchronized with the X-ray laser...
is available. Figure 5 shows a simple layout of AMO and CXI instruments. More detailed information can be found from reference [144–146] and from the LCLS facility website [147,148].

As mentioned in the setup and experiment procedure section, photon parameters should be determined before the experiment. The selection of the photon energy is very important to single particle imaging. As shown by momentum transfer $q = 4\pi \sin \theta / \lambda$ (2θ is the scattering angle), to obtain higher resolution, higher photon energy is needed. On the contrary, for higher photon energy, the wavelength is shorter and the coherent scattering cross-section is weaker. In order to estimate the scattering intensity per shot, a sphere model with uniform electron density can be used [149],

$$I(q) = I_0 r_e^2 \Delta \Omega |\Delta \rho|^2 \left(4\pi \frac{\sin(Rq) - Rq \cos(Rq)}{q^3}\right)^2$$  \hspace{1cm} (1)

where $I_0$ is the incident intensity, $r_e$ is the classical electron radius, $\Delta \rho$ is the difference of the complex electron density of the sphere to the medium and $R$ is the sphere radius. If we take the complex refractive index into the above equation, we can get the maximum ring intensity [150],

$$I_{max}(q) = I_0 r_e^2 \Delta \Omega |\Delta \rho|^2 16\pi^2 R^2 q^{-4}$$ \hspace{1cm} (2)

The intensity for high $q$ will decrease rapidly. For the same sample size and scattering angle, shorter wavelength will contribute to higher resolution but lower intensity. Therefore, the optimized photon energy should be chosen depends on proposed resolution and sample types.

**Figure 5.** Overview of Atomic, Molecular & Optical Science (AMO) and Coherent X-ray Imaging (CXI) instrument layout. Distances are indicated in meters from the interaction region (IR) for AMO, 1 μm sample chamber (SC) and in parentheses from the 100 nm SC for CXI. The X-ray beam enters the hutch and passes through the diagnostics (D) and slits (S) and is then focused by KB mirrors. (a) An optical laser in-coupling (L-IN) is located 0.4m upstream of the IR. Two pairs of prCCD detectors are located in different positions downstream of the IR; (b) For the CXI instrument, each chamber is colored to match its designed KB mirrors. A timing tool (TT) is designed to obtain the fine time between X-ray laser and pump laser. (Figures were reproduced from Reference [145,146] with permission from International Union of Crystallography/IUCr).
Another principle for the photon energy selection is the optimized X-ray energy range for specified experiment instruments. For different X-ray instruments at LCLS or different beamlines at SACLA, the optimized photon energy varies. The commonly used photon energy for SPI is 1700 eV that just below the Si K-edge at AMO, 7 keV at CXI that below the Fe edge of 7.1 keV, LCLS. Also, the photon count ability of detectors has also been considered during the photon energy selection. Other photon energies, such as 1250 eV, 1800 eV, 5 keV and 10 keV have also been used and tested, with varying degrees of success. A balance has to be struck between the resolution and scattering efficiency, and the ability for the various detectors to count photons with a reasonable signal to noise ratio.

High harmonics are an inevitable aspect of XFEL sources. Radiation at the fundamental wavelength dominates but appreciable levels of high harmonics also present at the 1% level. These harmonics may extend the capability of instruments but also may contribute background to experiments. The Soft X-ray Offset Mirror System (SOMS) and Hard X-ray Offset Mirror System (HOMS) located in the Front End Enclosure of LCLS have harmonic cutoffs at ~2.5 and ~25 keV respectively. The SOMS operate in the FEL energy range from 0.20 keV to 2.0 keV and the reflectivity is above 90% [151]. The system reflectivity above 2.48 keV is below 20%, which contributes to suppressing the third harmonic FEL peak [152]. The fundamental operation energy range for HOMS is 2.0~12.0 keV, and be able to deliver 2~25 keV photons up to the third harmonic. From former measurement, it is known that the second harmonic content in normal operation at soft X-ray region (near 1keV) is 0.04~0.1%, and the third harmonic is as high as 2.0~2.5% [153]. The third harmonic for hard X-ray wavelength (6~8 keV) is 0.2~2%. The reflectivity for the second and third harmonics are different for the downstream KB mirrors located at the experiment station, which provide some level of harmonic rejection. The third harmonic can produce undesired noise, for example via fluorescence by crossing above an absorption edge such as iron, a material making up most of the vacuum chamber. It is also less efficiently block by apertures and slits and can again increase the background noise.

Knowing and optimizing the focused beam size and the wavefront is another key aspect of SPI experiments [154]. The position and angles of KB mirrors should ideally be aligned for every SPI experiments. Imprint methods have been employed for the AMO and CXI instruments to find the best focusing position [155,156]. This is a time-consuming procedure for the current experiments. Two to three hours are usually required. According to the nature of SASE mode, the beam position and intensity fluctuates shot-to-shot. The SPI initiative has also taken the phenomenon into consideration. A backscattering position and intensity monitor was used for diagnostic for the CXI instruments [157].

The parasitic scattering of particle injectors is the primary source of scatter, the team is still working on this problem. Apart from particle injector scattering, the left stray scattering comes from the upstream components of the beamline. For the AMO instrument, the parasitic scattering comes from the roughness of KB mirrors. For the CXI instrument, the stray scattering comes from the diamond window that is located downstream of the KB mirrors to protect the mirrors from particles. The detailed information will come out soon by the SPI team. For SPI experiments, the alignment of apertures is also of great importance. Ge, Si, Si$_3$N$_4$ and B$_4$C apertures are typically used depending on the instrument and photon energy. Background levels from apertures of different materials have been investigated with varying performance depending on the material and thickness. For example, cleaved and etched Ge was found to be a good choice for hard X-rays around 7 keV.

The typical LCLS pulse energy for SPI is 2~5 mJ, equals to $7.80 \times 10^{12}$~$1.95 \times 10^{13}$ photons/pulse@1.6 keV and $1.78~4.46 \times 10^{12}$ photons/pulse@7.0 keV. The calculation of photon number per pulse was based on the 100% efficiency assumption of optical system. Actually, the efficiency is closer to 50%. More photons typically mean higher SNR with stability being desirable. A single diffraction pattern is just one slice from the 3D diffraction volume. The number of photons interacting with the sample is different due to the intensity fluctuations shot-to-shot. The side effects of intensity fluctuations to the SPI 3D diffraction volume also need further study. Figure 6 shows the pulse intensity fluctuation with shots (time), the common fluctuation of intensity is ~10%. Also, the focused beam position fluctuates. The relative
positions between X-ray laser beam and the sample are also different shot to shot. This leads to different incident photons onto samples and means that for SPI, is not so easy to normalize every frame.

![Figure 6](image.png)

**Figure 6.** Pulse energy fluctuation with time. The intensity and position fluctuations come from the origin of SASE. The common fluctuations are typically 10% but sometimes as high as 30%.

The pulse duration is another main factor for XFEL experiments. Short pulse duration is always required to outrun radiation damage. However, since shorter pulses usually come with a reduced number of photons, a balance is needed between pulse duration and pulse energy, a balance between damage and signal. For biological samples and molecules, Auger decay is predominant in carbon, nitrogen and oxygen [158]. The photoelectric effects will lead to a removal of two electrons from these elements. The energy and lifetime of these two electrons are different [159–161]. To figure out the exact Auger emission time scale and non-elastic scattering for specified samples is complex. However, the classic simulation and crystalline experiments have demonstrated that the radiation damage could be reduced or eliminated by using shorter pulses, such as <10 fs [100]. For SPI, to guarantee enough photons per pulse, the commonly used pulse duration is 30~70 fs. At the current limited resolution, these pulse durations do not lead to noticeable damage. For higher spatial resolution, radiation damage will be a limit for the development of SPI [25,162,163].

### 3.5. Sample Selection

For the development phase of SPI, the selection of samples is key. To make things easier, choosing a high Z material is tempting, but this is not very representative of samples that are the ultimate goal of the method with the scattering strength of high Z nanoparticles being stronger than bioparticles and biomolecules. Nevertheless, as initial steps towards developing aspects of the SPI methods, such artificial test samples can prove useful. Nanofabricated samples present the challenge of producing particles with regular shapes and sizes, a key requirement for putting together a consistent 3D diffraction volume from multiple copies of an object. This is also a challenge for bioparticles but less so.

The sample size should be smaller than the focused beam size. If the X-ray pulse only illuminates part of a single particle, one does not get a diffraction pattern representative of the whole object and therefore cannot merge this data reliably. As the sample quantities needed are large, the cost, mass production capacity should also be considered. High concentration should also be easy to achieve to improve the hit rate. Last but not least, the particles should be able to be aerosolized stably for injection to the XFEL beam. Under these principles, gold octahedra with size range from 2 µm to 100 nm were produced by a polylol process [164]. For bioparticles, RDV, PR772 and MS2 were selected. RDV (Rice
Dwarf Virus, Figure 7a) is an icosahedral RNA virus of about 70 nm in diameter [165]. A 3D structure of the capsid was determined by X-ray crystallography with a resolution of 3.5 Å. The associated PDB ID is 1UF2 [166]. PR772 (Figure 7b) is a lipid-containing bacteriophage that infects E. coli [167]. The diameter of this icosahedral virus is about 69 nm. Unfortunately, the inner arrangement and structures of lipid layer and DNA are also not clearly known. MS2 (Figure 7c) is a bacteriophage that infects F + E. coli. The diameter of this icosahedral virus is about 26 nm [168]. The internal arrangement of the complex is unknown.

![Figure 7. Projections of bioparticles used for SPI experiments. (a) Biological assembly of double-shelled rice dwarf virus (RDV). RDV is a member of the genus Phytoreovirus in the family Reoviridae. The atomic structure was determined by X-ray crystallography at 3.5 Å resolution [166]; (b) Quasi-atomic structure resolution model of bacteriophage PRD1 wild type virion. PR772 belongs to the PRD1 family. The dsDNA bacteriophage has a membrane inside its icosahedral capsid. The atomic structure was determined by combined cryo-EM and X-ray crystallography at 25 Å resolution [169]; (c) Crystal structures of MS2 coat protein mutants in complex with wild-type RNA operator fragments. MS2 is a group I RNA bacteriophage that infects Escherichia coli. The atomic structure was resolved by X-ray crystallography at a resolution of 2.8 Å [170]. The projections were generated by NSL Viewer, a WebGL based 3D viewer [171,172].](image)

3.6. Sample Delivery

Sample delivery is a key component of XFEL experiments. There are two mainly used methods: (a) fix the sample by solid support, fixed target method; (b) Inject the particle streams into X-ray laser beam path, injection method. For the first method, Si3N4 membrane or amorphous carbon film are regularly used. The method has been used for many 2D crystalline samples and synchrotron-based CDI experiments. However, the diffraction background is strong and can overwhelm the signal from the sample if Si3N4 is used. For particle injectors, there are many injector devices commonly used by scientists. The gas dynamic virtual nozzle (GDVN) injector [173], delivers samples inside an unbroken liquid stream with tunable diameter by changing nozzle diameter and gas flow rate. The main general drawback of the GDVN is that they don’t form droplets that are small enough. Also, non-volatile components in the buffer solution trend to stick to the particle of interest, which will make valid single particle shot more challenging. Another drawback of the GDVN is the high rate of sample consumption. This is not a problem when the sample is easy to achieve or synthesis. But this will be a big problem when the sample is valuable and hard to get. For SPI specifically, the liquid carrier medium scatters X-rays much more than the sample itself and makes it unsuitable for measuring single particle diffraction patterns of biological samples. To solve this problem, the GDVN is always used combine with aerodynamic lens stack or electrospray during the SPI experiments.

Another mainly used injector device is the aerosol injector. The particles can be focused by gradient pressure in the aerodynamic lens stack. The sample delivery method of choice for SPI is typically to transport the purified samples into the buffer solution and then aerosolized with helium gas using a GDVN and then introduced to the X-ray laser beam path via an aerodynamic lens. The purified samples could also be aerosolized by a gas nebulizer, such as electrospray [174], and then injected...
by the aerodynamic lens stack [175]. These unfortunately typically lead to low hit rates. For CXI nanofocusing, the hit rate is just \(~1\%\) or lower. The number of diffraction patterns needed for high resolution is large, requiring a lot of beamtime, beyond what is reasonably possible. This is an issue that will need to be resolved for SPI to become a broadly useful method. Another challenge for SPI is the scattering background from residual gas of aerosol injector. Different gases, such as He and CO\(_2\), have been tested and there are indications that the background level is now limited by the aerosol carrier gas.

3.7. Detector and Data Analysis

Detector systems are critical important to all scientific experiments and SPI is not an exception. The 2017 Chemistry Nobel Prize was awarded to Cryo-EM, a powerful technology for single-particle protein crystal structures determination [176]. The current resolution is around 3 Å, comparable with the X-ray crystallography [177]. About 20 years ago, the first 3D reconstruction at the sub-nanometer resolution of icosahedra virus was around 10 Å. Since then, thousands of structures have been determined by the Cryo-EM at a resolution from 30 Å to 3 Å [3]. A breakthrough was suddenly made around 2014. Great progress was made with the direct electron detectors and single particle analysis methods [178]. From that moment, Cryo-EM has attracted much attention from biologists and chemists. Compared with the Cryo-EM, there is a long way to go for SPI. The current 3D resolution of SPI is about 10 nm. The CXI nanofocusing data showed a post-sample aperture [179] limited resolution close to 5.9 Å [180].

Figure 8 shows the calculated photons number vs resolution (Q). The integrated single hit signal is higher than the background. A real-space image could not be obtained from this data due to the lack of enough hits. While the main limitation currently is hit rate, improved detectors with lower noise and easier identification of single scattered photons from the noise will be required to achieve higher resolution imaging. The SPI detector of the future will need to combine the best of dark current, detector panel size, gain, readout noise, dynamic range and quantum efficiency, with an increased readout speed. For LCLS, the maximum pulse repetition is 120 Hz. At the increased repetition rates of the European-XFEL and LCLS-II, new detectors are needed. Millions or more diffraction patterns are needed to obtain a high-resolution image. At the current hit rates of about 1%, higher repetition rate X-ray FELs will have a profound impact. The main characteristics of detectors used or planned for SPI related experiments at LCLS, LCLS-II, European-XFEL, SACLA and SwissFEL are listed in Table 1 for reference.

![Figure 8](image-url)  
**Figure 8.** Radial average of signals using hard X-rays. Elevated photon counts from the sample are visible up to an angle commensurate with 5.9 Å resolution, this being the resolution limit set by the angular acceptance of a post-sample aperture. (reproduced with permission from [180]. Copyright Springer Nature, 2016).
Table 1. Main characteristics of detectors used for LCLS, LCLS-II, European-XFEL and SACLA.

<table>
<thead>
<tr>
<th>Detector</th>
<th>AMO, LCLS</th>
<th>CXI, LCLS</th>
<th>TXI, LCLS-II</th>
<th>SPB/SFX, European-XFEL</th>
<th>BL 2, SACLA</th>
<th>SwissFEL</th>
</tr>
</thead>
<tbody>
<tr>
<td>Pixel Size (µm²)</td>
<td>75 × 75</td>
<td>110 × 110</td>
<td>100 × 100</td>
<td>200 × 200</td>
<td>50 × 50</td>
<td>75 × 75</td>
</tr>
<tr>
<td>Single Photon Sensitivity</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
<td>Yes</td>
</tr>
<tr>
<td>Quantum Efficiency</td>
<td>&gt;80%@0.3–12 keV</td>
<td>~97%@0.8 keV</td>
<td>~85%@5 keV</td>
<td>&gt;80%@0.3–25 keV</td>
<td>~85%@5.5 keV</td>
<td>Up to 85%@1 keV</td>
</tr>
<tr>
<td>Dynamic Range</td>
<td>10³@2 keV</td>
<td>3.5 × 10²@8 keV</td>
<td>10⁴@8 keV</td>
<td>&gt;10⁴@12.5 keV</td>
<td>1.2 × 10³@6 keV</td>
<td>&gt;10⁴@12 keV</td>
</tr>
<tr>
<td>Noise (e⁻)</td>
<td>20/2 a</td>
<td>300</td>
<td>120</td>
<td>265</td>
<td>300</td>
<td>100</td>
</tr>
<tr>
<td>Frame Rate (kHz)</td>
<td>0.12</td>
<td>0.12</td>
<td>0.48/2<del>4/10</del>20 c</td>
<td>4500</td>
<td>0.06</td>
<td>0.1~2.4</td>
</tr>
</tbody>
</table>

a For pnCCD, the readout noise is 20 e⁻ for low gain, 2 e⁻ for high gain [181].
b The dynamic range and ASIC noise for CSPAD under high gain mode are 350 photons@8 keV and 300 e⁻ r.m.s. For low gain mode, they're 2700 photons@8 keV and 1000 e⁻ r.m.s [182].
c The current version is about 480 Hz. For digital domain multiplexing, the frame rate will be 2–4 kHz. For fast ADCs, the frame rate will be 10–20 kHz [183,184].
d See reference [185,186] for detailed information.
e Keeping the single photon detection capability for X-ray photon energy higher than 6 keV [187].
f See reference [188] for detailed information.
Data analysis is obviously key to the final results. As XFEL beamtime is rare and precious around the world, to optimize the experimental parameters before the formal experiment and data collection period is of great importance to guarantee the success and save beamtime. Simulations based on physical theories, actual light source and instrument specifications will be a great help. The SPB/SFX instrument of the European XFEL created a start-to-end simulation (S2Esim) software (European-XFEL, Hamburg, Germany) [189] to help researchers figure out the optimized parameters for SPI experiments based on European XFEL accelerator and undulator data bank. Recently, a powerful program was designed for SPI to demonstrate single particle imaging under ultra-shot X-ray pulses [190]. LCLS is planning to leverage these developments from the European XFEL. Other open sources, such as condor [191], provided by Uppsala University can simulate speckle patterns, reconstructed images and evaluated resolution that based on photon energy, focusing beam spot size, sample type and detector, etc. These will help researchers design and optimize their experiments.

The quantity of raw data of XFEL experiments makes it fall under the big data category. Raw data files contain electron and photon beams parameters on a shot by shot basis, instrument settings and motor positions, diagnostics and DAQ information. How to extract useful information from the raw data efficiently is challenging. To provide a user-friendly solution, LCLS, European-XFEL and SACLA created their own DAQ systems [192]. At the LCLS, data analysis department developed psana module that a python-script interfaces could be used online (real-time) offline and parallelized over many machines [193]. This data analysis strategy makes SPI data analysis easier by using building blocks.

Online data monitoring is also an important part of SPI experiments. To give an instant feedback from the SPI data collection, a Python-based software named Hummingbird (Uppsala University, Uppsala, Sweden) [194] was developed. This gives the needed fast feedback for the particle injector and instruments alignment or optimization.

Offline analysis of such big data sets is challenging. The LCLS data analysis department developed psocake [195], a GUI program that makes SPI data analysis simple. The input of experiment name, run number and detector ID will make diffraction data visible. Different masks, different algorithms for hit finding and multiple types of pixel readout (gain corrected ADU, common mode corrected ADU, pedestal corrected ADU, raw ADU and photon counts) make diffraction patterns preliminary analysis (e.g., ADUs to photons, background subtraction, hit finding) powerful and effective.

Apart from the shot-to-shot intensity variation, non-linear detector response, stray scattering from optics and injectors, sample heterogeneity and conformations mentioned above, multiple particle hits are also a challenge factor for offline data analysis. Significant progress has been made in classification algorithms by using diffusion maps [196]. Experimental data contains only intensities with no phase information. Diffusion map algorithms provide mathematical links to a cloud of points via the Laplace-Beltrami operator. Each point on a diffusion map represents a diffraction pattern as shown on Figure 9 [197]. Single hit, multiple-particle hit, water diffraction, background and defects from the detector are captured in such mapping. Diffusion map approaches will fail in the limit of strong background and low SNR for small particles (e.g., MS2). For that situation, the classification can be conducted by hand. This is time-consuming and the precision will be non-reproducible for different operators. To solve this problem, automatic and supervised machine learning methods are being developed. The convolutional neural network is based on VGG16 net. For training, simulated data and experiments data are both used. Further study is still needed but this represents a promising future approach.

After classification, orientation determination and phase retrieval are needed. The commonly used methods are generative topographic mapping (GTM) [198], expectation maximization compression (EMC) [199,200], correlation maximization [201], manifold [202,203] and angular correlation methods [204]. The current method of choice for orientation determination is EMC. The EMC algorithm is implemented in Dragonfly [205], which is a powerful python-script program. Figure 10 shows a 3D diffraction volume after orientation determination and assembly [206]. The associated 3D real-space image is reconstructed by error-reduction (ER) method. Many other phase retrieval algorithms could
be used, such as hybrid-input-output (HIO), Guided-hybrid-input-output (GHIO), relaxed averaged alternating reflections (RAAR) and difference map (DM).

![Diffusion Map of all the hits](image1)

**Figure 9.** Diffusion map analysis of all hits. Large data sets were reduced to single-particle hit patterns. (a) Single-particle hit; (b) multiple-particle hit; (c) water diffraction that may contain contaminant residue from samples and buffer solutions; (d) background diffraction from detector; (e) detector defect pattern. (reproduced with permission from [197]. Copyright Springer Nature, 2017).

![Three-dimensional diffraction pattern and reconstructed structure](image2)

**Figure 10.** Three-dimensional diffraction pattern and reconstructed structure obtained without conformational analysis. (a) Diffraction pattern extracted from 37,550 2D single-particle diffraction snapshots of the PR772 virus, obtained at LCLS; (b) Corresponding 3D reconstructed image with a resolution of 9 nm, corresponding to scattering to the edge of the detector. (reproduced with permission from [206]. Copyright Springer Nature, 2017).

Recently, great progress has been made in real-space image reconstruction phase retrieval algorithms, multi-tiered iterative phasing (M-TIP) [207]. M-TIP is an extension of standard iterative phasing algorithms, which recover the 3D internal intensity directly from fluctuation X-ray scattering data [208]. The angular cross-correlations method makes a valuable statistical tool for structural analysis. The approach in the case of scattering also offers a valuable opportunity for multi-particle analysis. Figure 11 shows the recovered 3D structures of RDV and PR772 by MTIP. A non-uniform distribution of internal structures was obtained.

**4. Summary and Future Prospects**

Since the start of the SPI initiative, eight experiments have been completed to try to overcome the technical challenges in achieving atomic resolution in single particles imaging with XFELs at the
Linac Coherent Light Source. Two data papers have been published to describing experimental details and progress to date. Progress was also made by the SPI initiative members developing conformation change detection and new phase retrieval algorithm. The goals of past SPI experiments mainly focused on light source and instruments optimization, sample preparations and delivery development, background reduction and data analysis methods. The team achieved measurement signals at ~6 Å resolution, to the corner of the CSPAD detector used with the 100 nm-focusing system of the CXI instrument. At the moment, the data is insufficient to reconstruct the 3D real-space image. On the other hand, hundreds of thousands of diffraction patterns were recorded by a far-field pnCCD at the AMO instrument using soft X-rays. Different team members have successfully reconstructed 3D real-space images using different methods at a full-period resolution of ~10 nm. Some of the SPI beamtime have been dedicated to the improvement of sample injection. Different injection methods, such as GDVN and electrospray for aerosolization, have been tested to reduce the background. This is still a challenge for further experiments. For the data analysis, classification has made rapid progress via the use of diffusion maps and machine learning. Powerful programs, such as psana, Condor, Hummingbird, Ondata, Dragonfly have made great contributions to SPI.

![Three-dimensional reconstructed images of RDV and PR772 virus](image)

**Figure 11.** Three-dimensional reconstructed images of RDV (top row) and PR772 virus (bottom row). Two different views of the reconstructed RDV (a,b) and PR772 (d,e) particles, as well as density plots showing nonuniformities in the internal distribution of material inside the viruses (c,f). (reproduced with permission from [207]. Copyright American Physical Society, 2017).

For higher resolution in the near future, such as 5 Å or better, more challenges lay ahead. The reproducibility of samples and homogeneity of internal structures are hard to guarantee. The hit rate and sample contaminations will have a great influence on the validity of patterns and numbers of valid frames. Higher resolution means more frames, this also requires more semi- and automatic data analysis methods. Not only are enough frames needed for 3D reconstructions but they also need enough photons in each frame for interpretation above noise. To totally outrun the radiation damage, the pulse duration should be reduced from 40 fs to below 10 fs without too much loss in flux. High QE, high dynamic range and large array pixel area detector will also be a bottleneck for higher resolution approach using higher repetition rate machines. Fortunately, the European XFEL and LCLS-II are both developing such detectors.

A new tendency in scientific research is to share the data, sources and codes to the public [209–211]. With data sharing, the validity and repeatability of the analysis and interpretation can be tested by different institutes and personnel [212–216]. “Open science, data sharing, software sharing is the future of science”, Carly Strasser says [209]. For SPI, this concept has also been accepted and will be extended to a wider range [217–220]. At the moment, most published data has been uploaded to the Coherent X-ray Imaging Data Bank (CXIDB) [221,222]. The community can download the raw data and try to reproduce the results. Commonly used tools can also be obtained easily from Github [223] or facility.
websites [224]. The move to make scientific findings transparent will speed up the challenging project and improve the scientific outcome.

Moving forward and overcoming the technical challenges can be painful, but this necessary method development effort is improving the prospects of single particle imaging with XFEL. High resolution X-ray based single particle imaging will make dynamic changes, light-induced phenomena, phase transition and femtosecond chemistry & catalysis valuable possibility. This will provide a new horizon to the scientific community to explore the ultra-small and ultrafast world. The potential rewards are worth the effort and will only benefit from the advent of high repetition rate of state-of-the-art X-ray FELs such as the European-XFEL and LCLS-II.

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Author Contributions: Z.S. wrote the paper. All authors reviewed and critiqued the manuscript.

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